

Notice of References Cited

Application/Control No.

10/020,240

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

Roland G. Foster

Art Unit

2645

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,893,037	04-1999	Reele et al.	455/556.1
	B	US-6,535,243 B1	03-2003	Tullis, Barclay J.	348/207.1
	C	US-6,564,070 B1	05-2003	Nagamine et al.	455/556.1
	D	US-6,573,938 B1	06-2003	Schulz et al.	348/373
	E	US-6,741,864 B2	05-2004	Wilcock et al.	455/456.1
	F	US-2001/0026376 A1	10-2001	I'Anson, Colin	358/400
	G	US-2002/0066115 A1	05-2002	Wendelrup, Heino	725/153
	H	US-2003/0030839 A1	02-2003	Walters et al.	358/1.15
	I	US-2003/0103144 A1	06-2003	Sesek et al.	348/207.1
	J	US-6,642,959 B1	11-2003	Arai, Tatsuo	348/231.3
	K	US-5,943,603	08-1999	Parulski et al.	725/133
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.